

Anti-interference shielding system

Anti interference EMI/Spectral noise/external light closed shielding cavity, cavity with the surface of conductive oxide and nickel plating process, to ensure the conduction state between the parts so as to achieve the shielding effect, reduce the system noise, blocking interference effectively, and provide low leakage current protection, provides the best test environment for the weak electric signal test;At the same time, the closed chamber in the low temperature environment to avoid the test sample condensation, to ensure the wafer and device under the high and low temperature environment fast and safe reliability test.

Independent research and development of software integration system, more compatibility

Support semi-automatic control (manual test or automatic test). Automatic Wafer calibration automatic Wafer mapping automatic die size measurement automatic align automatic test data can be accessed remotely. Automatic calibration of RF probe module with one key, automatic needle clearing function. One-key adaptive four-axis Chuck precision calibration, supporting micron pad point measurement. Single point or continuous testing can be supported. Strong data storage capacity and data processing capacity. The bin value can be divided to determine the device NG. Multi-system integration to upgrade the operating system application system and device test system independently. Intuitive and simple operation design, quick and easy operation, effective saving operation training time.

Flexible optional configuration and extension

Convenient instrument access and support system automatic expansion and upgrade, temperature control system loading;There are also a variety of test modules available. According to the test module, it can be used together with a variety of positioner fixtures, needle CARDS and probe tables, such as six-axis positioner RF cables.Many system operating parameters and features reach the highest level of the industry, can meet your different test needs, but also an ideal choice for more industry customers a semi-automatic probe table equipment.

3) V Series New Generation High Performance Probe Station